

Search Notes

Application/Control No.

10/675,555

Examiner

Steven Loke

Applicant(s)/Patent under
Reexamination

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Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	529, 528, 153	11/2/2004	TM
438	132, 215	11/2/2004	TM
438	601, 281	11/2/2004	TM
updated	searched	2/20/2006	sl

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR